

CIL
CRITICAL ITEMS LIST
FILE: CIL21

NAME P/N QTY	CRIT	FAILURE MODE & CAUSES		FAILURE EFFECT	RATIONALE FOR ACCEPTANCE
		ELECTRICAL	POWER HARNESS ITEM 151 SV749361-6 (1)		
ELECTRICAL POWER HARNESS ITEM 151 SV749361-6 (1)	2/2	151FH12; ELECTRICAL OPEN OR SHORT FEEDERED OPEN/CLOSE LINES.	EMI EMI; ELECTRICAL OPEN OR SHORT TO GND IN FEEDERED OPEN/CLOSE LINES. THESE LINES ARE CURRENT LIMITED TO .7 ± .2 AMPS ON THE DCW.	EMI EMI; ELECTRICAL OPEN OR SHORT TO GND IN FEEDERED OPEN/CLOSE LINES. THESE LINES ARE CURRENT LIMITED TO .7 ± .2 AMPS ON THE DCW.	A. DESIGN - OPEN AND SHORT CIRCUITS IN ANY OF THE CIRCUITS IN THE ITEM 151 HARNESS ARE MINIMIZED BY THE FOLLOWING: CONDUCTORS ARE HELD POSITIONED IN STYCAST 2461 IN THE AREA THAT THEY INTERFACE WITH THE METAL BACKSHELLS TO MINIMIZE THEIR MOVEMENT AND CHANCE OF SHORTING TO THE BACKSHELL. THE CONDUCTORS ARE STRAIN RELIEVED AT THE CONNECTOR/HARNESS INTERFACE WITH A MOLDED RUBBER BACKSHELL. THIS MINIMIZES THE EFFECTS OF CABLE TENSION ON THE INDIVIDUAL CONNECTORS. CONNECTORS ARE SCREWED MEDIUMLY A MOVED NYLON OUTER LAYER. THIS HOLDS THE CABLES TOGETHER TO SHARE ANY LOADING. EACH CONNECTOR/ADAPTER RING INTERFACE IS LOCKED IN PLACE TO PREVENT ROTATION BY A MECHANICAL AND ADHESIVE LOCK. B22 AND B24 AND TEFLON INSULATED WIRES PROVIDE ELECTRICAL AND MECHANICAL PROPERTIES TO PREVENT WIRE BREAKAGE AND TO HELP PREVENT SHORTING. MORE CHINMING IS PER SUBSECTION 4 BASED ON MIL-C-SPEC-B-241.
5159-1	1	CAUSE: CABLE CHAFING AGAINST CONNECTOR SHELL OR SHIELD. INSULATOR CONNECTOR STRAIGHT RELIEF. FAULTY CONNECTION BETWEEN THE CONNECTOR AND THE LEAD WIRES.	OFF SURFACE; LOSS OF POWER TO 157 VALVE. UNABLE TO CHANGE POSITION OF FEEDERED VALVE (157). IF CLOSED, NO COOLING OR DEHUMIDIFICATION AVAILABLE.	MISSION: REHEATING/EVA. LOSS OF EMU.	B. TEST - COMPARTMENT ACCEPTANCE: THE HARNESS IS ACCEPTANCE TESTED PER THE FOLLOWING TESTS OF AT-100-151 TO ENSURE THERE ARE NO NONMANUFACTURE PROBLEMS WHICH MIGHT CAUSE ACTUAL OR POTENTIAL OPEN OR SHORT CIRCUITS. FULL TEST - THIS TEST SUBJECTS EACH CONNECTOR/HARNESS INTERFACE TO A SPECIFIC FULL TEST IN POSITION DESIGNED TO EXCEED ANY STRESS ENCOUNTERED IN ACTUAL USE. THE INSULATION RESISTANCE BETWEEN EACH CONDUCTOR AND THE GROUND CIRCUIT IS MEASURED DURING THE TEST TO ENSURE THERE IS NO SHORTING. THE TEST IS FOLLOWED BY A CONTINUITY CHECK OF EACH CONDUCTOR PATH TO ENSURE THERE ARE NO OPEN CIRCUITS. CONTINUITY TEST - THE RESISTANCE OF EACH CIRCUIT IS MEASURED TO ENSURE THERE ARE NO OPEN CIRCUITS OR HIGH RESISTANCE PATHS. INSULATION RESISTANCE/DIELECTRIC STRENGTH TESTING - THE HARNESS IS TESTED FOR SHORT CIRCUITS OR LOW RESISTANCE PATHS BETWEEN EACH CONDUCTOR TO THE SHIELD CIRCUIT(S) AND BETWEEN EACH CONDUCTOR TO EACH OTHER CONDUCTOR BY INSULATION RESISTANCE AND DIELECTRIC STRENGTH MEASUREMENTS AT 200 VDC AND 200 VAC RESPECTIVELY.

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Critical Items List
FILE: C217/1

NAME	P/N	FAILURE	FAILURE EFFECT	RATIONALE FOR ACCEPTANCE
		HOLE & CLEAUSES		
ELECTRICAL	2/2	ISOLATOR; ELECTRICAL OPEN OR SHORT FEEDWATER OPEN/CLOSE LINES.		
POWER				POA TEST - AN OPEN OR SHORT CIRCUIT IN THE FEEDWATER OPEN/CLOSE LINES WOULD BE DETECTED DURING THE FEEDWATER LINE FLOW RATE PORTION OF PSS POA TESTING PER PARA. II.0 OF SEMI-60-000.
WIRENESS				
ITEM 163				
SY789151-4				
(1)				

B159-2

D

CERTIFICATION TEST -
THIS ITEM COMPLETED ONE 15 YEAR STRUCTURAL VIBRATION AND
SHOCK CERTIFICATION REQUIREMENT DURING JAP/83. EC'S
42804-527-E (ISOLATION RESISTANCE CHECK DURING PULL TEST)
AND 42806-615 (REMOVAL CRIMP SPLICES) HAVE BEEN INCORPORATED
AND CERTIFIED BY TEST SINCE THIS CONFIGURATION HAS
CERTIFIED.

C. INSPECTION -
DURING HARNESS MANUFACTURING, THE FOLLOWING INSPECTIONS
ARE PERFORMED:
VISUAL INSPECTION OF CONDUCTORS PRIOR TO POTTING
OPERATIONS TO ENSURE THERE ARE NO DAMAGED CONDUCTORS AND
THAT THE CONDUCTORS ARE ROUTED PROPERLY.
VISUAL INSPECTION OF THE HARNESS PRIOR TO AND AFTER
NUMBER 1000 HOLDING PROCESS TO ENSURE THERE ARE NO DAMAGED
CONDUCTORS WHICH COULD CAUSE AN OPEN OR SHORT CIRCUIT.
IN-PROCESS ELECTRICAL CHECKOUT OF THE HARNESS BEFORE AND
AFTER POTTING AND HOLDING TO ENSURE THERE ARE NO OPEN OR
SHORT CIRCUITS.
VISUAL INSPECTION OF THE CONDUCTORS PRIOR TO APPLICATION
OF THE OUTER SHEATH TO ENSURE THERE ARE NO DAMAGED
CONDUCTORS THAT COULD CAUSE AN OPEN OR SHORT CIRCUIT.
CONNECTOR CONTACT CRIMP SAMPLES ARE MADE PRIOR TO AND
AFTER CRIMPING AND SUBJECTED TO PULL TESTING TO ENSURE THE
CRIMPING TOOLS ARE OPERATING PROPERLY. THIS INSURES THERE
WILL NOT BE ANY HIGH RESISTANCE PROBLEMS AT THE CONTACTS.

D. FAILURE HISTORY -
THE FOLLOWING RDR's HAVE BEEN ISSUED FOR ITEM 163 DUE TO OPEN
CIRCUITS:
R-EU-260-0001 (7-8-85)
INTERMITTENT OPEN DUE TO A BROKEN WIRE AT THE P12
CONNECTOR DURING ACCEPTANCE TESTING. THIS FAILURE WAS
CAUSED BY A MANUFACTURING PROBLEM. THE CORRECT ACTION TAKEN
WAS TO ADD A VISUAL INSPECTION PRIOR TO HOLDING.

100-100-300
100-100-300

CIL
CRITICAL ITEMS LIST
FLEET CIL7/I

NAME	P/N	QTY	CRIT	FAILURE	FAILURE CAUSES	FAILURE EFFECT	RATIONALE FOR ACCEPTANCE
ELECTRICAL				POWER	MODE 3		
POWER				HARNESS	OPEN OR SHORT		
HARNESS				ITEM 161	FLOODED		
ITEM 161				SY789161-4	OPEN/CLOSE		
				111	LINES.		
				8159-3			
							D. FAILURE HISTORY - (CONTINUED)
							H-EMU-161-008 (16-32-851) INTERMITTENT OPEN DUE TO A BROKEN WIRE AT THE P3 CONNECTOR DURING ACCEPTANCE TESTING DUE TO A WORKMANSHIP PROBLEM. THE CORRECTIVE ACTION TAKEN HAD TO ISSUE EC 42804-527 WHICH FIXES THE ANGULAR LOCATION OF THE P3 ADAPTER RING SLOT TO INSURE PROPER WIRE EXET AND EC 42804-527-2 WHICH REQUIRES THAT A FULL TEST BE PERFORMED TO DETECT SPEWS OR SHREWS.
							E. FOLLOWING RON'S MEAS ISSUED FOR ITEM 161 FAILURES CAUSED BY SHORT CIRCUITS:
							H-EMU-161-009 (16-32-857) SHORT CIRCUIT BETWEEN A P3 CONNECTOR CONDUCTOR AND THE ADAPTER RING CAUSED BY AN IMPROPER REWORK THAT ROTATED THE CONNECTOR ADAPTER RING/CONNECTOR ASSEMBLY 20 DEGREES RELATIVE TO THE MOLDED RUBBER FORM. THIS FORCES THE CONDUCTORS AGAINST THE ADAPTER RING SLOT EDGE AND A SHORT CIRCUIT RESULTED. CORRECTIVE ACTION: EC'S 42804-527 AND 527-2 HAVE BEEN ISSUED TO SPECIFY AN ANGULAR LOCATION REQUIREMENT BETWEEN THE ADAPTER RING SLOT AND THE MASTER KEYWAY TO FULL TEST EACH CONNECTOR/HARNESS INTERFACE.
							J-EMU-161-006 AND J-6161-161-005 (16-32-851) - BOTH FAILURES OCCURRED DURING AND AFTER AIRLOCK SUPPLY FUNCTIONAL TEST. THE FAILURE HERE CAUSED BY A SHORT CIRCUIT BETWEEN THE EVC POWER/BATTERY SENSE (+1 LINE AND CASE GROUND) CONNECTOR BODY. THE FAILURE CAUSED THE SLOT RETURN LINE IN THE OEM TO FUSE OPEN. THE FAILURE INVESTIGATION FOUND THAT A CRIMP SPLICER WITHIN THE MOLDED BACKSHELL WAS NOT SUFFICIENTLY COVERED BY SHRINK TUBING. THE EXPOSED PORTION OF THE CRIMP HAS ALLOWED TO COME IN CONTACT WITH THE CONNECTOR BODY. CORRECTIVE ACTION: CLASS I EC 42804-527-2 CREATED THE SY789161-3 HARNESS CONFIGURATION BY ADDING A CONNECTOR FULL TEST REQUIREMENT TO THE ACCEPTANCE TEST REQUIREMENTS. CLASS I EC 42804-865 CREATED THE SY789161-4 HARNESS CONFIGURATION BY ELIMINATING THE TWO CRIMP SPLICES INT EH P3 CONNECTOR, TO PREVENT THEM FROM SHORTING TO CASE.
							F. GROUND WORKAROUND - TESTED PER FEMU-N-008, ITEM 137 (FEEDWATER VALVE) ACTIVATION.

COTI EVENS TEST
FILE: CIC721

NAME	P/N	QTY	CAUSE	FAILURE EFFECT	REASONABLE FOR ACCEPTANCE
ELECTRICAL					F. OPERATIONAL USE -
POWER	2/2		ISBFM021		CORE RESPONSE - PRE-EVA: TROUBLESHOOT PROBLEM. CONSIDER
HARNESS			ELECTRICAL		THIRD EMU IF AVAILABLE. IF NO SUCCESS, CONTINUE EVA PREP.
ITEM 151			OPEN OR SHUNT		EVA WHEN CMS DATA CONFIRMS LOSS OF SUBLIMATION PRESSURE
SV289261-4			FEEDHOLDEN		DUE TO FAILED CLOSED VALVE AND COOLING IS NOT ADEQUATE.
C11			OPEN/CLOSE		DEMONSTRATE EVA. WHEN FAILED OPEN VALVE IS DETECTED BY WATER
			LINES.		IN AIRLOCK DURING REPRESS, PERFORM WATER DRAIN OF FEEDHOLDEN
0054-6					TANKS. CONSIDER VACUUM WATER RECHARGE PRIOR TO SUBSEQUENT
					EVA.
					TRAINING - STANDARD TRAINING COVERS THIS FAILURE MODE.
					OPERATIONAL CONSIDERATIONS - EVA CHECKLIST PROCEDURES
					VERIFY HARNESS INTEGRITY AND SYSTEM OPERATIONAL STATUS
					PRIOR TO EVA. REAL TIME DATA SYSTEM ALLOWS GROUND
					MONITORING OF EMU SYSTEMS. FLIGHT RULES BEFORE BOOTH GO
					CITERIA RELATED TO EMU THERMAL CONTROL.

SCD1
SCD2
SCD3
SCD4